


<p style="text-align: center;">Search Notes</p> 	<p>Application/Control No.</p> <p>10523993</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>KIM, YONG-NYUN</p>
	<p>Examiner</p> <p>Bouchelle, Laura A</p>	<p>Art Unit</p> <p>3763</p>

SEARCHED			
Class	Subclass	Date	Examiner
604	264,197,199,405,406,256,263	6/19/07	LAB
128	205.12	6/19/07	LAB
604	199	3/17/08	LAB
128	766	3/17/08	LAB

SEARCH NOTES		
Search Notes	Date	Examiner
text search see EAST search history	6/19/07	LAB
search updated	3/17/08	LAB
Forward and Backward citation search	3/17/08	LAB
Inventor search	3/17/08	LAB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
604	405,256,264	3/17/08	LAB